

## Zero-Drift, Rail-to-Rail I/O CMOS Operational Amplifiers

#### 1 FEATURES

• Qualified for Automotive Applications

AEC-Q100 Qualified with the Grade 1

Low Offset Voltage: ±10uV (TYP)

Input Offset Drift: ±0.05µV/°C

High Gain Bandwidth Product: 4.3MHz

• Rail-to-Rail Input and Output

• High Gain, CMRR, PSRR: 120dB

High Slew Rate: 2.5V/µs

Low Noise: 0.93uVp-p (0.1Hz~10Hz)

• Low Power Consumption: 650µA/op amp

Overload Recovery Time: 1us

Low Supply Voltage: +2.7V to +5.5V

• No External Capacitors Required

Extended Temperature: -40°C to +125°C

#### **2 APPLICATIONS**

- Automotive Applications:
  - ADAS
  - Body Electronics and Lighting
  - Current Sensing
  - Battery Management Systems
- Temperature Sensors
- Medical/Industrial Instrumentation
- Pressure Sensors
- Battery-Powered Instrumentation

#### **3 DESCRIPTIONS**

The RS8557-Q1, RS8558-Q1, RS8559-Q1 series of CMOS operational amplifiers use auto-zero techniques to simultaneously provide very low offset voltage (100µV max) and near-zero drift over time and temperature. This family of amplifiers has ultralow noise, offset and power.

This miniature, high-precision operational amplifiers offset high input impedance and rail-to-rail input and rail-to-rail output swing. With high gain-bandwidth product of 4.3MHz and slew rate of 2.5V/µs.

Single or dual supplies as low as +2.7V ( $\pm 1.35V$ ) and up to +5.5V ( $\pm 2.75V$ ) may be used.

The RS8557-Q1/RS8558-Q1/RS8559-Q1 are specified for the extended industrial and automotive temperature range (-40°C to 125°C). The RS8557-Q1 single amplifier is available in 5-lead SOT23, The RS8558-Q1 dual amplifier is available in 8-lead SOIC and 8-lead MSOP narrow surface mount packages, the RS8559-Q1 quad amplifier is available in 14-lead SOIC and 14-lead narrow TSSOP packages.

#### **Device Information (1)**

PART NUMBER	PACKAGE	BODY SIZE (NOM)
RS8557-Q1	SOT23-5	2.92mm×1.62mm
RS8558-Q1	SOIC-8(SOP8)	4.90mm×3.90mm
K30556-Q1	MSOP-8	3.00mm×3.00mm
RS8559-Q1	SOIC-14 (SOP14)	8.65mm×3.90mm
1100000 Q1	TSSOP-14	5.00mm×4.40mm

<sup>(1)</sup> For all available packages, see the orderable addendum at the end of the data sheet.



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**4 Revision History**Note: Page numbers for previous revisions may different from page numbers in the current version.

Version	Change Date	Change Item
A.1	2023/03/01	Initial version completed



### 5 PACKAGE/ORDERING INFORMATION (1)

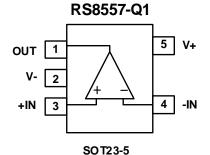
Orderable Device	Package Type	Pin	Channel	Lead finish/Ball material <sup>(2)</sup>	MSL Peak Temp <sup>(3)</sup>	Op Temp (°C)	Device Marking <sup>(4)</sup>	Package Qty
RS8557XF -Q1	SOT23-5	5	1	NIPDAUAG	MSL1-260° -Unlimited	-40°C ~ 125°C	8557	Tape and Reel,3000
RS8558XK -Q1	SOIC-8 (SOP8)	8	2	NIPDAUAG	MSL1-260° -Unlimited	-40°C ~125°C	RS8558	Tape and Reel,4000
RS8558XM -Q1	MSOP-8	8	2	NIPDAUAG	MSL1-260° -Unlimited	-40°C ~125°C	RS8558	Tape and Reel,4000
RS8559XP -Q1	SOIC-14 (SOP14)	14	4	NIPDAUAG	MSL1-260° -Unlimited	-40°C ~125°C	RS8559	Tape and Reel,4000
RS8559XQ -Q1	TSSOP- 14	14	4	NIPDAUAG	MSL1-260° -Unlimited	-40°C ~125°C	RS8559	Tape and Reel,4000

#### NOTE:

- (1) This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the right-hand navigation.
- (2) Lead finish/Ball material. Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (3) MSL Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the lot trace code information (data code and vendor code), the logo or the environmental category on the device.



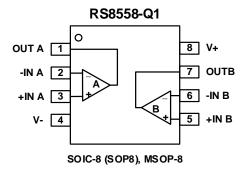
### **6 Pin Configuration and Functions (Top View)**



### **Pin Description**

	PIN		
NAME	RS8557-Q1	I/O <sup>(1)</sup>	DESCRIPTION
	SOT23-5		
-IN	4	I	Negative (inverting) input
+IN	3	I	Positive (noninverting) input
OUT	1	0	Output
V-	2	-	Negative (lowest) power supply
V+	5	-	Positive (highest) power supply

<sup>(1)</sup> I = Input, O = Output.



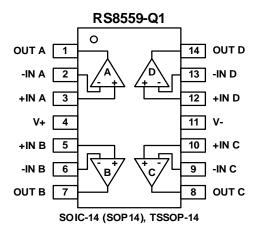
### **Pin Description**

NAME	NAME		DESCRIPTION	
NAME	SOIC-8 (SOP8)/ MSOP8	I/O <sup>(1)</sup>	DESCRIF HON	
-INA	2	I	Inverting input, channel A	
+INA	3	I	Noninverting input, channel A	
-INB	6	I	Inverting input, channel B	
+INB	5	I	Noninverting input, channel B	
OUTA	1	0	Output, channel A	
OUTB	7	0	Output, channel B	
V-	4	-	Negative (lowest) power supply	
V+	8	-	Positive (highest) power supply	

<sup>(1)</sup> I = Input, O = Output.



## Pin Configuration and Functions (Top View)



### **Pin Description**

NAME	PIN	I/O <sup>(1)</sup>	DESCRIPTION	
NAME SOIC-14 (SOP14)/ TSSOP-14		1/0 (1)	DESCRIPTION	
-INA	2	I	Inverting input, channel A	
+INA	3	I	Noninverting input, channel A	
-INB	6	I	Inverting input, channel B	
+INB	5	I	Noninverting input, channel B	
-INC	9	I	Inverting input, channel C	
+INC	10	I	Noninverting input, channel C	
-IND	13	I	Inverting input, channel D	
+IND	12	I	Noninverting input, channel D	
OUTA	1	0	Output, channel A	
OUTB	7	0	Output, channel B	
OUTC	8	0	Output, channel C	
OUTD	14	0	Output, channel D	
V-	11	-	Negative (lowest) power supply	
V+	4	-	Positive (highest) power supply	

<sup>(1)</sup> I = Input, O = Output.



#### 7 SPECIFICATIONS

### 7.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT
	Supply, V <sub>S</sub> =(V+) - (V-)		7		
Voltage	Signal input pin (2)		(V-)-0.5	(V+) +0.5	V
	Signal output pin (3)		(V-)-0.5	(V+) +0.5	
Signal input pin (2)			-10	10	mA
Current	Signal output pin (3)		-55	55	mA
	Output short-circuits (4)		Con	Continuous	
		SOT23-5		230	
		SOIC-8(SOP8)		110.88	°C/W
$\theta_{JA}$	Package thermal impedance (5)	MSOP-8		165.7	
		SOIC-14(SOP14)		104.5	
		TSSOP14		89.21	
	Operating range, T <sub>A</sub>	-40	125		
Temperature	Junction, T <sub>J</sub> <sup>(6)</sup>	Junction, T <sub>J</sub> <sup>(6)</sup>			°C
	Storage, T <sub>stg</sub>	-65	150		

<sup>(1)</sup> Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

- (4) Short-circuit to ground, one amplifier per package.
- (5) The package thermal impedance is calculated in accordance with JESD-51.
- (6) The maximum power dissipation is a function of  $T_{J(MAX)}$ ,  $R_{\theta JA}$ , and  $T_A$ . The maximum allowable power dissipation at any ambient temperature is  $P_D = (T_{J(MAX)} T_A) / R_{\theta JA}$ . All numbers apply for packages soldered directly onto a PCB.

#### 7.2 ESD Ratings

The following ESD information is provided for handling of ESD-sensitive devices in an ESD protected area only.

			VALUE	UNIT
		Human-Body Model (HBM), per AEC Q100-002 (1)	±2000	V
$V_{(ESD)}$	Electrostatic discharge	Charged-Device Model (CDM), per AEC Q100-011	±500	V
		Latch-Up (LU), per AEC Q100-004	±100	mA

<sup>(1)</sup> AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.



#### **ESD SENSITIVITY CAUTION**

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 7.3 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply voltage Va- (VI) (V	Single-supply	2.7		5.5	\/
Supply voltage, V <sub>S</sub> = (V+) - (V-)	Dual-supply	±1.35		±2.75	V

<sup>(2)</sup> Input terminals are diode-clamped to the power-supply rails. Input signals that can swing more than 0.5V beyond the supply rails should be current-limited to 10mA or less.

<sup>(3)</sup> Output terminals are diode-clamped to the power-supply rails. Output signals that can swing more than 0.5V beyond the supply rails should be current-limited to ±55mA or less.



### 7.4 ELECTRICAL CHARACTERISTICS

Boldface limits apply over the specified temperature range, Full  $^{(9)}$  = -40°C to +125°C. (At T<sub>A</sub>= +25°C, V<sub>S</sub>=5V, R<sub>L</sub>= 10k $\Omega$  connected to V<sub>S</sub>/2, and V<sub>OUT</sub>= V<sub>S</sub>/2, unless otherwise noted.)  $^{(1)}$ 

D4D411====	0)/1/20:	CONDITION	_	RS8557-8-9-Q1			
PARAMETER	SYMBOL		TJ	MIN <sup>(2)</sup>	<b>TYP</b> (3)	MAX <sup>(2)</sup>	UNIT
OFFSET VOLTAGE							
Include Official Voltage		V - V /0	25°C	-50	±10	50	\/
Input Offset Voltage	Vos	s V <sub>CM</sub> = V <sub>S</sub> /2	Full	-100		100	μV
Input Offset Voltage Average Drift	V <sub>OS</sub> Tc		Full		±0.05		μV/°(
Davis Committee Dation Dation	DODD	V <sub>S</sub> = +2.7V to +5.5V	25°C	105	120		-10
Power-Supply Rejection Ratio	PSRR	V <sub>CM</sub> <v<sub>S-2V</v<sub>	Full	90			dB
Channel Separation, dc			25°C		0.13		μV/V
INPUT BIAS CURRENT							
Input Bias Current (4) (5)	lΒ	V <sub>CM</sub> = V <sub>S</sub> /2	25°C		±50		pА
Input Offset Current (5)	los	V <sub>CM</sub> = V <sub>S</sub> /2	25°C		±10		pА
NOISE PERFORMANCE							
Input Voltage Noise	e <sub>n</sub> p-p	f= 0.1Hz to 10Hz	25°C		0.93		μVpp
Input Voltage Noise Density (5)	en	f= 1KHz	25°C		45		nV/√I
INPUT VOLTAGE RANGE							
Common-Mode Voltage Range	Vсм		Full	(V-)-0.1		(V+)+0.1	V
0 11 1 5 1 11 5 11	CMRR	(V-)-0.1V <v<sub>CM&lt;(V+)+0.1V</v<sub>	25°C	105	120		dB
Common-Mode Rejection Ratio			Full	100			
INPUT CAPACITANCE	•		•	•		•	
Differential			25°C		1		pF
Common-Mode			25°C		25		рF
DYNAMIC PERFORMANCE							
Slew Rate (8)	SR	G= +1	25°C		2.5		V/µs
Gain-Bandwidth Product	GBW		25°C		4.3		MHz
Overload Recovery Time	tor		25°C		1		us
OUTPUT CHARACTERISTICS							
0 1 1/4 0:		R <sub>L</sub> = 10KΩ	25°C	105	120		ID.
Open-Loop Voltage Gain	Aol	Vo= 0.3V to 4.7V	Full	105			dB
		D 40 KO t- OND	25°C		8	20	>/
	V <sub>OH</sub>	R <sub>L</sub> =10 KΩ to GND	Full			30	mV
Voltage output swing from rail		D 40 KO t- V/	25°C		8	20	
	V <sub>OL</sub>	$R_L$ =10 KΩ to V+	Full			30	mV
Chart Circuit Comment (6) (7)			25°C	±30	±48		A
Short-Circuit Current (6) (7)	Isc		Full	±25			mA
POWER SUPPLY	•						•
Operating Voltage Range	Vs		25°C	2.7		5.5	V
Ouissant Oumset! A!!#:		\/ -5\/	25°C		0.65	1.05	, A
Quiescent Current/ Amplifier	ΙQ	V <sub>S</sub> =5V	Full			1.1	mA

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#### NOTE:

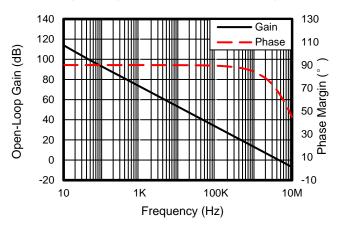
- (1) Electrical table values apply only for factory testing conditions at the temperature indicated. Factory testing conditions result in very limited self-heating of the device.
- (2) Limits are 100% production tested at 25°C. Limits over the operating temperature range are ensured through correlations using statistical quality control (SQC) method.
- (3) Typical values represent the most likely parametric norm as determined at the time of characterization. Actual typical values may vary over time and will also depend on the application and configuration.
- (4) Positive current corresponds to current flowing into the device.
- (5) This parameter is ensured by design and/or characterization and is not tested in production.
- (6) The maximum power dissipation is a function of  $T_{J(MAX)}$ ,  $R_{\theta JA}$ , and  $T_A$ . The maximum allowable power dissipation at any ambient temperature is PD =  $(T_{J(MAX)} T_A) / R_{\theta JA}$ . All numbers apply for packages soldered directly onto a PCB.
- (7) Short circuit test is a momentary test.
- (8) Number specified is the slower of positive and negative slew rates.
- (9) Specified by characterization only.



#### 7.5 TYPICAL CHARACTERISTICS

NOTE: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only.

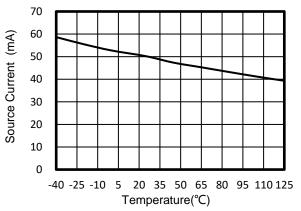
At  $T_{A}$ = +25°C,  $V_{S}$ = 5V,  $R_{L}$ = 10k $\Omega$  connected to  $V_{S}/2$ ,  $V_{OUT}$  =  $V_{S}/2$ , unless otherwise noted.



10K (Yd) treating 100 100 -40 -25 -10 5 20 35 50 65 80 95 110 125 Temperature (°C)

Figure 1. Open-Loop Gain and Phase vs Frequency

Figure 2. Input Bias Current vs Temperature



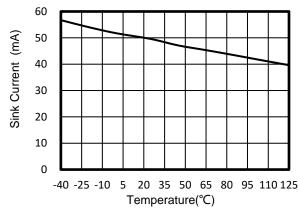
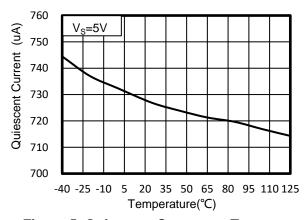


Figure 3. Source Current vs Temperature

Figure 4. Sink Current vs Temperature



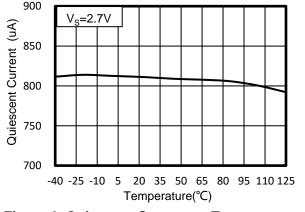


Figure 5. Quiescent Current vs Temperature

Figure 6. Quiescent Current vs Temperature



#### TYPICAL CHARACTERISTICS

NOTE: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only.

At  $T_A$ = +25°C,  $V_S$ = 5V,  $R_L$ = 10k $\Omega$  connected to  $V_S/2$ ,  $V_{OUT}$ =  $V_S/2$ , unless otherwise noted.

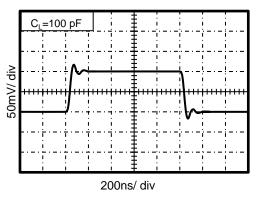


Figure 7. Small-Signal Step Response

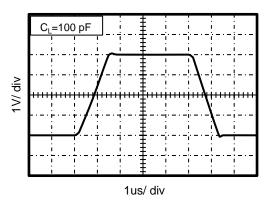


Figure 8. Large-Signal Step Response

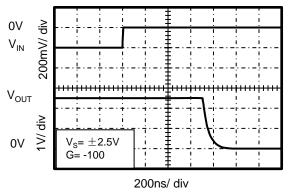


Figure 9. Positive Overvoltage Recovery

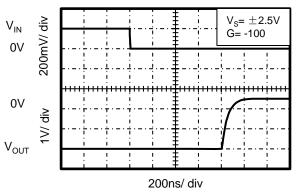


Figure 10. Negative Overvoltage Recovery

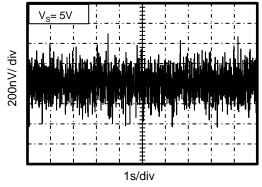


Figure 11. 0.1Hz to 10Hz Noise

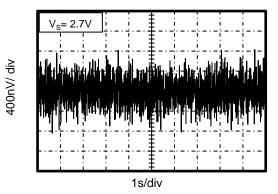


Figure 12. 0.1Hz to 10Hz Noise



### **8 Detailed Description**

#### 8.1 Overview

The RS8557-Q1, RS8558-Q1, RS8559-Q1 series op amps are unity-gain stable and free from unexpected output phase reversal. They use auto-zeroing techniques to provide low offset voltage and very low drift over time and temperature.

Good layout practice mandates use of a 0.1µF capacitor placed closely across the supply pins.

For lowest offset voltage and precision performance, circuit layout and mechanical conditions should be optimized. Avoid temperature gradients that create thermoelectric (Seebeck) effects in thermocouple junctions formed from connecting dissimilar conductors. These thermally-generated potentials can be made to cancel by assuring that they are equal on both input terminals.

- Use low thermoelectric-coefficient connections (avoid dissimilar metals).
- Thermally isolate components from power supplies or other heat-sources.
- Shield op amp and input circuitry from air currents, such as cooling fans.

Following these guidelines will reduce the likelihood of junctions being at different temperatures, which can cause thermoelectric voltages of 0.1µV/°C or higher, depending on materials used.

#### **8.2 OPERATING VOLTAGE**

The RS8557-Q1, RS8558-Q1, RS8559-Q1 series op amps operate over a power-supply range of +2.7V to +5.5V (±1.35V to ±2.75V). Supply voltages higher than 7V (absolute maximum) can permanently damage the amplifier. Parameters that vary over supply voltage or temperature are shown in the Typical Characteristics section of this data sheet.



### 9 Application and Implementation

Information in the following applications sections is not part of the RUNIC component specification, and RUNIC does not warrant its accuracy or completeness. RUNIC's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 APPLICATION NOTE

#### **Typical Applications**

#### 9.2 Bidirectional Current-Sensing

This single-supply, low-side, bidirectional current-sensing solution detects load currents from -1A to 1A. The single-ended output spans from 110mV to 3.19V. This design uses the RS8557-Q1, RS8558-Q1, RS8559-Q1 because of its low offset voltage and rail-to-rail input and output. One of the amplifiers is configured as a difference amplifier and the other provides the reference voltage.

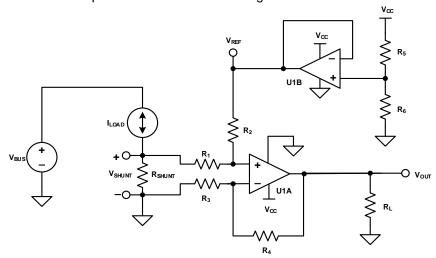


Figure 13. Bidirectional Current-Sensing Schematic

#### 9.3 Design Requirements

This solution has the following requirements:

• Supply voltage: 3.3V

• Input: -1 A to 1 A

• Output: 1.65V ±1.54V (110mV to 3.19V)

#### 9.4 Detailed Design Procedure

The load current,  $I_{LOAD}$ , flows through the shunt resistor ( $R_{SHUNT}$ ) to develop the shunt voltage,  $V_{SHUNT}$ . The shunt voltage is then amplified by the difference amplifier, which consists of U1A and  $R_1$  through  $R_4$ . The gain of the difference amplifier is set by the ratio of  $R_4$  to  $R_3$ . To minimize errors, set  $R_2$ =  $R_4$  and  $R_1$ =  $R_3$ . The reference voltage,  $V_{REF}$ , is supplied by buffering a resistor divider using U1B. The transfer function is given by Equation 1.  $V_{OUT}$ = $V_{SHUNT}$  $\times$  Gain Diff Amp + $V_{REF}$ 

Where

 $V_{SHUNT}=I_{LOAD}\times R_{SHUNT}$ 

$$Gain_{Diff\_Amp} = \frac{R_4}{R_2}$$

$$V_{REF} = V_{CC} \times \left[ \frac{R_6}{R_5 + R_6} \right] \tag{1}$$

There are two types of errors in this design: offset and gain. Gain errors are introduced by the tolerance of the shunt resistor and the ratios of  $R_4$  to  $R_3$  and, similarly,  $R_2$  to  $R_1$ . Offset errors are introduced by the voltage divider ( $R_5$  and  $R_6$ ) and how closely the ratio of  $R_4/R_3$  matches  $R_2/R_1$ . The latter value impacts the CMRR of the



difference amplifier, which ultimately translates to an offset error. Because this is a low-side measurement, the value of  $V_{SHUNT}$  is the ground potential for the system load. Therefore, it is important to place a maximum value on  $V_{SHUNT}$ . In this design, the maximum value for  $V_{SHUNT}$  is set to 100 mV. Equation 2 calculates the maximum value of the shunt resistor given a maximum shunt voltage of 100 mV and maximum load current of 1 A.

$$R_{SHUNT(Max)} = \frac{V_{SHUNT(Max)}}{I_{LOAD(Max)}} = \frac{100 \text{ mV}}{1 \text{ A}} = 100 \text{ m}\Omega$$
(2)

The tolerance of R<sub>SHUNT</sub> is directly proportional to cost. For this design, a shunt resistor with a tolerance of 0.5% was selected. If greater accuracy is required, select a 0.1% resistor or better.

The load current is bidirectional; therefore, the shunt voltage range is -100 mV to 100 mV. This voltage is divided down by  $R_1$  and  $R_2$  before reaching the operational amplifier, U1A. Take care to ensure that the voltage present at the noninverting node of U1A is within the common-mode range of the device. Therefore, it is important to use an operational amplifier, such as the RS8557-Q1, RS8558-Q1, and RS8559-Q1 that has a common-mode range that extends below the negative supply voltage. Finally, to minimize offset error, note that the RS8557-Q1, RS8558-Q1, RS8559-Q1 has a typical offset voltage of  $\pm 3\mu V$  ( $\pm 20\mu V$  maximum). Given a symmetric load current of -1A to 1A, the voltage divider resistors ( $R_5$  and  $R_6$ ) must be equal. To be consistent with the shunt resistor, a tolerance of 0.5% was selected. To minimize power consumption,  $\pm 100$  resistors were used. To set the gain of the difference amplifier, the common-mode range and output swing of the RS8557-Q1, RS8558-Q1, and RS8559-Q1 must be considered. Equation 3 and Equation 4 depict the typical common-mode range and maximum output swing, respectively of the RS8557-Q1, RS8558-Q1, and RS8559-Q1 given a 3.3V supply.

$$-100 \text{mV} < V_{\text{CM}} < 3.4 \text{V}$$
 (3)

$$100 \text{mV} < V_{\text{OUT}} < 3.2 \text{V}$$
 (4)

The gain of the difference amplifier can now be calculated as shown in Equation 5.

$$Gain_{Diff\_Amp} = \frac{V_{OUT\_Max} - V_{OUT\_Min}}{R_{SHUNT} \times (I_{MAX} - I_{MIN})} = \frac{3.2 \text{ V} - 100 \text{ mV}}{100 \text{ m}\Omega \times [1 \text{ A} - (-1 \text{A})]} = 15.5 \frac{\text{V}}{\text{V}}$$
(5)

The resistor value selected for  $R_1$  and  $R_3$  was  $1k\Omega$ .  $15.4k\Omega$  was selected for  $R_2$  and  $R_4$  because it is the nearest standard value. Therefore, the ideal gain of the difference amplifier is 15.4 V/V.

The gain error of the circuit primarily depends on  $R_1$  through  $R_4$ . As a result of this dependence, 0.1% resistors were selected. This configuration reduces the likelihood that the design requires a two-point calibration. A simple one-point calibration, if desired, removes the offset errors introduced by the 0.5% resistors.

#### 9.5 Application Curve

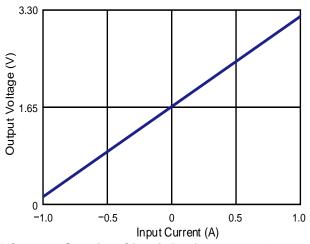


Figure 14. Bidirectional Current-Sensing Circuit Performance: Output Voltage vs Input Current



#### 10 LAYOUTS

#### 10.1 Layout Guidelines

Attention to good layout practices is always recommended. Keep traces short. When possible, use a PCB ground plane with surface-mount components placed as close to the device pins as possible. Place a 0.1uF capacitor closely across the supply pins.

These guidelines should be applied throughout the analog circuit to improve performance and provide benefits such as reducing the EMI susceptibility.

#### 10.2 Layout Example

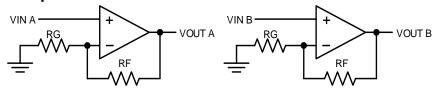


Figure 15. Schematic Representation

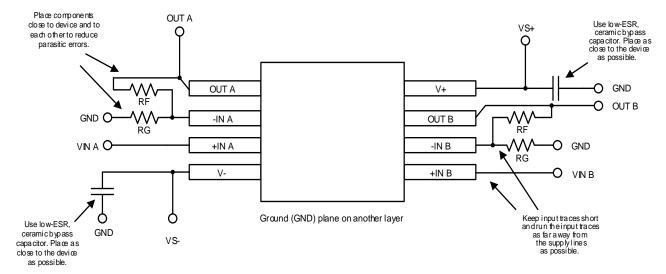
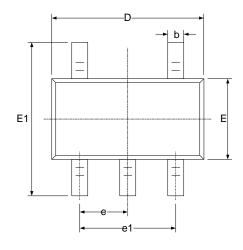


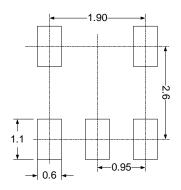
Figure 16. Layout Example

NOTE: Layout Recommendations have been shown for dual op-amp only, follow similar precautions for Single and four.

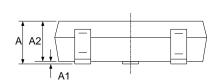


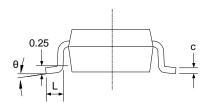
# 11 PACKAGE OUTLINE DIMENSIONS SOT23-5





### **RECOMMENDED LAND PATTERN (Unit: mm)**

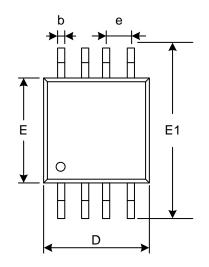


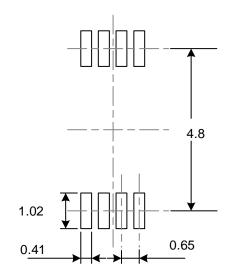


Symbol	Dimensions I	n Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
А		1.250		0.049
A1	0.000	0.150	0.000	0.006
A2	1.000	1.200	0.039	0.047
b	0.360	0.500	0.014	0.020
С	0.100	0.200	0.004	0.008
D	2.826	3.026	0.111	0.119
E	1.526	1.726	0.060	0.068
E1	2.600	3.000	0.102	0.118
е	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.350	0.600	0.014	0.024
θ	0°	8°	0°	8°

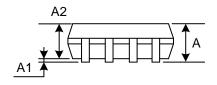


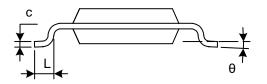
### MSOP-8





RECOMMENDED LAND PATTERN (Unit: mm)

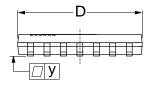


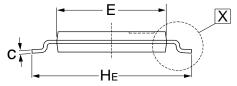


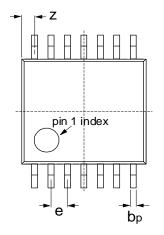
Symbol	Dimensions I	n Millimeters	Dimensions In Inches			
	Min	Max	Min	Max		
А	0.820	1.100	0.032	0.043		
A1	0.020	0.150	0.001	0.006		
A2	0.750	0.950	0.030	0.037		
b	0.250	0.380	0.010	0.015		
С	0.090	0.230	0.004	0.009		
D	2.900	3.100	0.114	0.122		
е	0.650	(BSC)	0.026(BSC)			
E	2.900	3.100	0.114	0.122		
E1	4.750	5.050	0.187	0.199		
L	0.400	0.800	0.016	0.031		
θ	0°	6°	0°	6°		

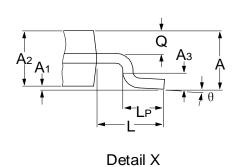


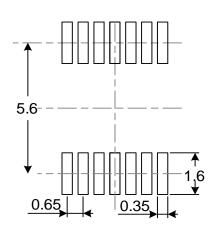
### TSSOP-14









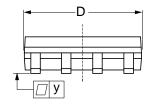


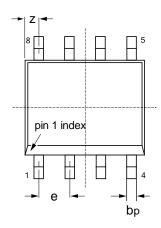
RECOMMENDED LAND PATTERN (Unit: mm)

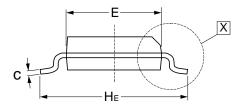
Symbol	Dimensions	n Millimeters	Dimensions In Inches				
	Min	Max	Min	Max			
А		1.100		0.043			
A <sub>1</sub>	0.050	0.150	0.002	0.006			
A <sub>2</sub>	0.800	0.950	0.031	0.037			
A <sub>3</sub>	0.	25	0.0	10			
bp	0.190	0.300	0.007	0.012			
С	0.100	0.200	0.004	0.008			
D <sup>(A)</sup>	4.900	5.100	0.193	0.201			
E <sup>(B)</sup>	4.300	4.500	0.169	0.177			
HE	6.200	6.600	0.244	0.260			
е	0.6	650	0.0	0.026			
L	,	1	0.039				
Lp	0.500	0.750	0.020	0.030			
Q	0.300	0.400	0.012	0.016			
Z <sup>(A)</sup>	0.380	0.720	0.015	0.028			
у	0	.1	0.004				
θ	0°	8°	0°	8°			

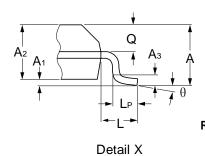


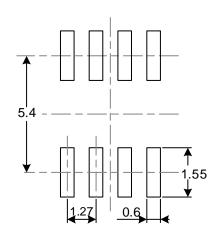
### SOIC-8(SOP8)









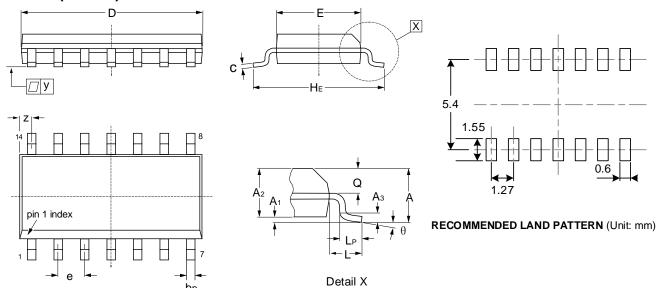


RECOMMENDED LAND PATTERN (Unit: mm)

Symbol	Dimensions	In Millimeters	Dimensions In Inches			
Symbol	Min	Max	Min	Max		
А		1.750		0.069		
A <sub>1</sub>	0.100	0.250	0.004	0.010		
A <sub>2</sub>	1.250	1.450	0.049	0.057		
A <sub>3</sub>	0.	25	0.0	010		
bp	0.360	0.490	0.014	0.019		
С	0.190	0.250	0.007	0.010		
D <sup>(A)</sup>	4.800	5.000	0.190	0.200		
E <sup>(B)</sup>	3.800	4.000	0.150	0.160		
HE	5.800	6.200	0.228	0.244		
е	1.2	270	0.050			
L	1.	05	0.041			
Lp	0.400	1.000	0.016	0.039		
Q	0.600	0.700	0.024	0.028		
Z <sup>(A)</sup>	0.300	0.700	0.012	0.028		
у	0	.1	0.004			
θ	0°	8°	0°	8°		



### SOIC-14(SOP14)



Symbol	Dimensions I	n Millimeters	Dimensions In Inches			
	Min	Max	Min	Max		
А		1.750		0.069		
A <sub>1</sub>	0.100	0.250	0.004	0.010		
A <sub>2</sub>	1.250	1.450	0.049	0.057		
A <sub>3</sub>	0	25	0.0	010		
bp	0.360	0.490	0.014	0.019		
С	0.190	0.250	0.007	0.010		
D <sup>(A)</sup>	8.550	8.750	0.340	0.350		
E <sup>(A)</sup>	3.800	4.000	0.150	0.160		
HE	5.800	6.200	0.228	0.244		
е	1.2	270	0.050			
L	1.0	05	0.041			
L <sub>P</sub>	0.400	1.000	0.016	0.039		
Q	0.600	0.700	0.024	0.028		
Z <sup>(A)</sup>	0.300	0.700	0.012	0.028		
у	0.	.1	0.004			
θ	0°	8°	0°	8°		



#### NOTE:

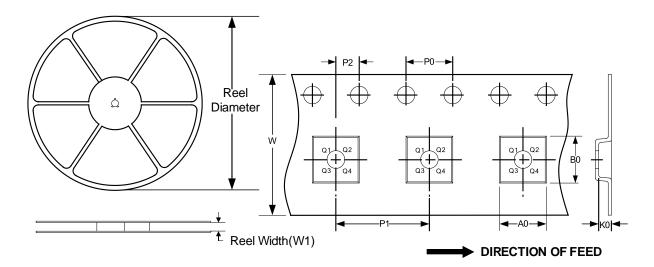
- A. Plastic or metal protrusions of 0.15mm maximum per side are not included.
- B. Plastic interlead protrusions of 0.25mm maximum per side are not included.
- C. All linear dimension is in millimeters.
- D. This drawing is subject to change without notice.

  E. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- F. BSC: Basic Dimension. Theoretically exact value shown without tolerances.



## 12 TAPE AND REEL INFORMATION REEL DIMENSIONS

#### **TAPE DIMENSION**



NOTE: The picture is only for reference. Please make the object as the standard.

#### **KEY PARAMETER LIST OF TAPE AND REEL**

Package Type	Reel Diameter	Reel Width (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P0 (mm)	P1 (mm)	P2 (mm)	W (mm)	Pin1 Quadrant
SOT23-5	7"	9.5	3.20	3.20	1.40	4.0	4.0	2.0	8.0	Q3
MSOP8	13"	12.4	5.20	3.30	1.50	4.0	8.0	2.0	12.0	Q1
TSSOP14	13"	12.4	6.95	5.60	1.20	4.0	8.0	2.0	12.0	Q1
SOIC-8 (SOP8)	13"	12.4	6.40	5.40	2.10	4.0	8.0	2.0	12.0	Q1
SOIC-14 (SOP14)	13"	16.4	6.60	9.30	2.10	4.0	8.0	2.0	16.0	Q1

NOTE:

<sup>1.</sup> All dimensions are nominal.

<sup>2.</sup> Plastic or metal protrusions of 0.15mm maximum per side are not included.



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